Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/661,880	MISURA ET AL.	
Examiner	Art Unit	
Sharidan Carrillo	1746	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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